

Over Three Decades of Quality Through Innovation

# **LSK489**

LOW NOISE LOW CAPACITANCE MONOLITHIC DUAL N-CHANNEL JFET AMPLIFIER

FEATURES	
ULTRA LOW NOISE	$e_n = 1.8 \text{nV}/\sqrt{\text{Hz}}$
LOW INPUT CAPACITANCE	Ciss = 4pF

#### **Features**

- Reduced Noise due to process improvement
- Monolithic Design
- High slew rate
- Low offset/drift voltage
- Low gate leakage lgss & lg
- High CMRR 102 dB

#### **Benefits**

- Tight differential voltage match vs. current
- Improved op amp speed settling time accuracy
- Minimum Input Error trimming error voltage
- Lower intermodulation distortion

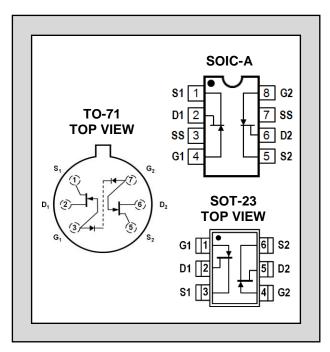
#### **Applications**

- Wide band differential Amps
- High speed temperature compensated single ended input amplifier amps
- High speed comparators
- Impedance Converters

#### Description

The LSK 489 series of high performance monolithic dual JFETs features extremely low noise, tight offset voltage and low drift over temperature specifications, and is targeted for use in a wide range or precision instrumentation applications. This series has a wide selection of offset and drift specifications. The SST series SO-8 package provided ease of manufacturing and the symmetrical pinout prevents improper orientation. The SO-8 package is available with tape and reel options for compatibility with automatic assembly methods. (See packaging data)

ABSOLUTE MAXIMUM RATINGS <sup>1</sup> @ 25 °C (unless otherwise stated)					
Maximum Temperatures					
Storage Temperature	-55 to +150°C				
Junction Operating Temperature	-55 to +150°C				
Maximum Power Dissipation, TA = 25°C					
Continuous Power Dissipation, per side <sup>4</sup>	300mW				
Power Dissipation, total <sup>5</sup>	500mW				
Maximum Currents					
Gate Forward Current	$I_{G(F)} = 10mA$				
Maximum Voltages					
Gate to Source	$V_{GSO} = 60V$				
Gate to Drain	V <sub>GDO</sub> = 60V				



<sup>\*</sup> For equivalent single version, see LSK189

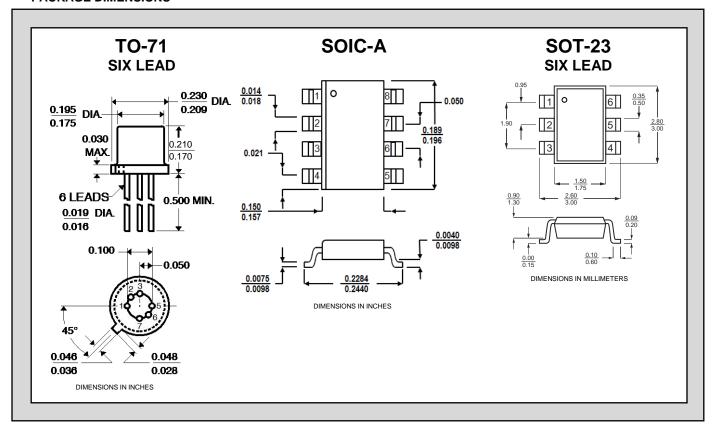
## MATCHING CHARACTERISTICS @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
$\left V_{GS1}-V_{GS2}\right $	Differential Gate to Source Cutoff Voltage			20	mV	$V_{DS} = 10V, I_{D} = 1mA$
	Gate to Source Saturation Current Ratio	0.9		1.0		V <sub>DS</sub> = 10V, V <sub>GS</sub> = 0V
CMRR	COMMON MODE REJECTION RATIO -20 $\log  \Delta V_{GS1-2}/\Delta V_{DS} $	95	102		dB	$V_{DS} = 10V \text{ to } 20V, I_D = 200\mu\text{A}$

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
<b>e</b> n	Noise Voltage		2.0		nV/√Hz	$V_{DS} = 15V$ , $I_{D} = 2.0$ mA, $f = 1$ kHz, NBW = 1Hz
en	Noise Voltage		3.5		nV/√Hz	$V_{DS} = 15V$ , $I_{D} = 2.0$ mA, $f = 10$ Hz, NBW = 1Hz
Ciss	Common Source Input Capacitance		4	8	pF	
C <sub>RSS</sub>	Common Source Reverse Transfer Capacitance			3	pF	$V_{DS} = 15V$ , $I_{D} = 500\mu A$ , $f = 1MHz$

## ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
BV <sub>GSS</sub>	Gate to Source Breakdown Voltage	-60			V	$V_{DS} = 0$ , $I_D = -1nA$
V(BR)G1 - G2	Gate to Gate Breakdown Voltage	±30	±45		V	I <sub>G</sub> = ±1µA, I <sub>D</sub> =I <sub>S</sub> =0 A (Open Circuit)
V <sub>GS(OFF)</sub>	Gate to Source Pinch-off Voltage	-1.5		-3.5	V	V <sub>DS</sub> = 15V, I <sub>D</sub> = 1nA
$V_{GS}$	Gate to Source Operating Voltage	-0.5		-3.5	V	$V_{DS} = 15V, I_D = 500\mu A$
I <sub>DSS</sub> <sup>2</sup>	Drain to Source Saturation Current	2.5	5	15	mA	$V_{DG} = 15V$ , $V_{GS} = 0$
1-	Gate Operating Current		-2	-25	pА	$V_{DG} = 15V, I_D = 200\mu A$
l <sub>G</sub>			-0.8	-10	nA	T <sub>A</sub> = 125°C
Igss	Gate to Source Leakage Current			-100	pА	$V_{DG} = -15V, V_{DS} = 0$
G <sub>fs</sub>	Full Conductance Transconductance	1500			μS	$V_{DG} = 15V, V_{GS} = 0, f = 1kHz$
Gfs	Transconductance	1000	1500		μS	$V_{DG} = 15V, I_D = 500\mu A$
Gos	Full Output Conductance			40	μS	$V_{DG} = 15V$ , $V_{GS} = 0$
Gos	Output Conductance		1.8	2.7	μS	$V_{DG} = 15V, I_D = 200\mu A$
NF	Noise Figure			0.5	dB	$V_{DS} = 15V, V_{GS} = 0, R_{G} = 10M\Omega,$ f = 100Hz, NBW = 6Hz

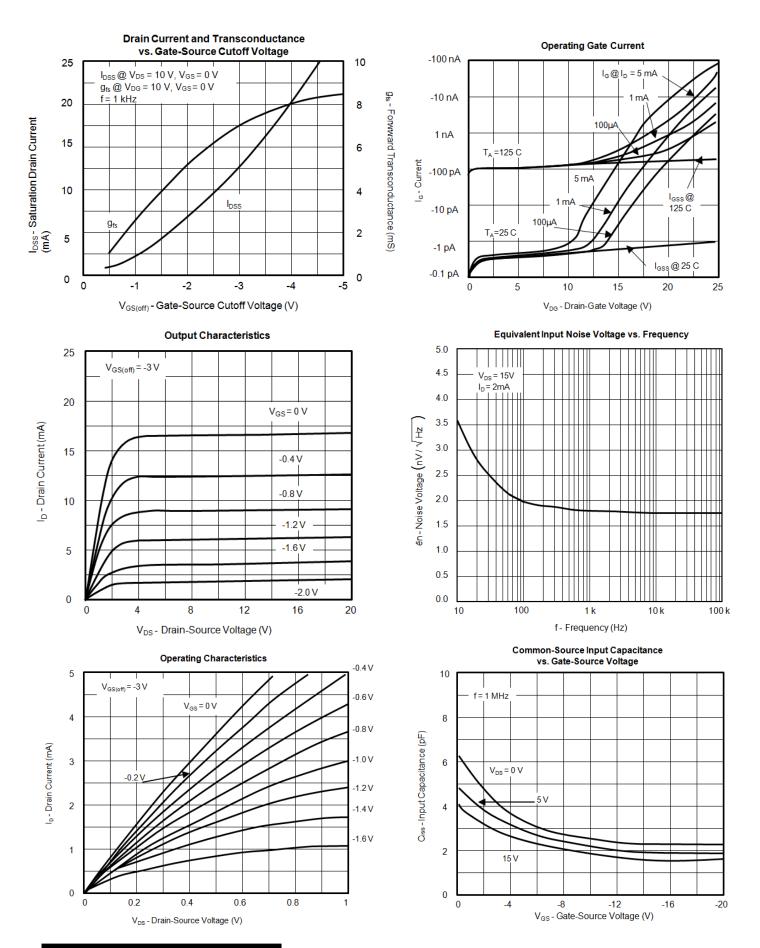


## **NOTES**

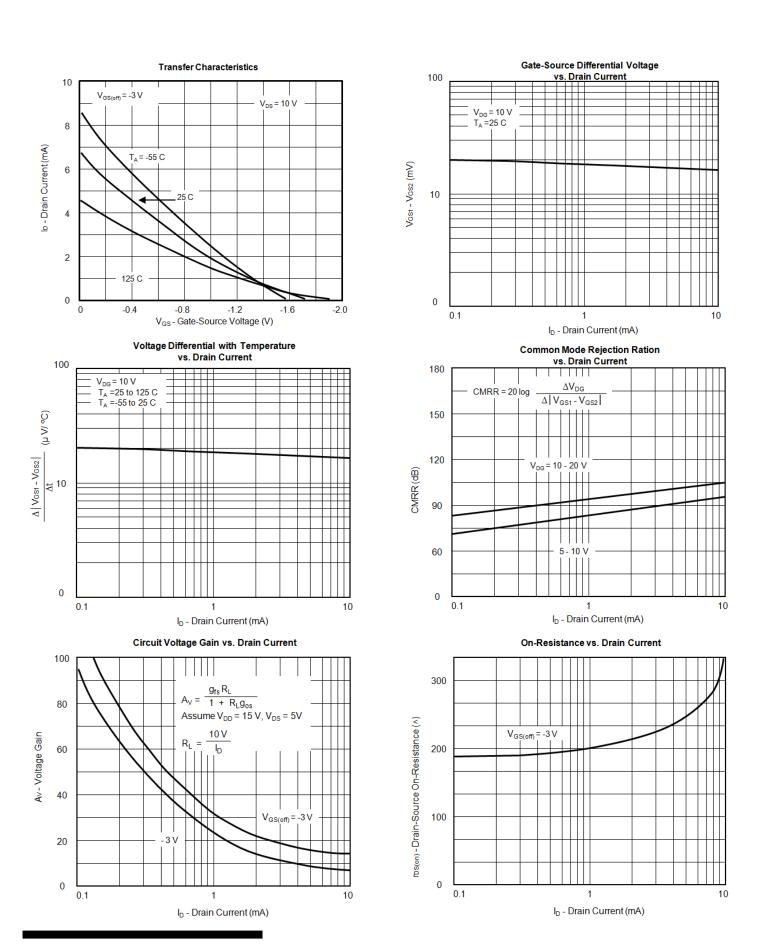
- 1. Absolute maximum ratings are limiting values above which serviceability may be impaired.
- 2. Pulse width ≤2<sub>ms</sub>
- 3. All MIN/TYP/MAX Limits are absolute values. Negative signs indicate electrical polarity only.
- 4. Derate 2.4 mW/°C above 25°C.
- 5. Derate 4 mW/°C above 25°C.

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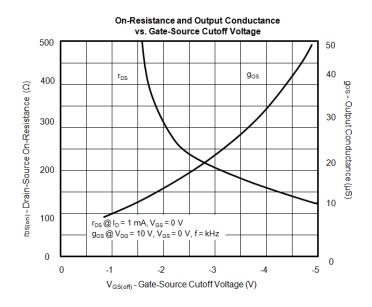
# **Typical Characteristics**

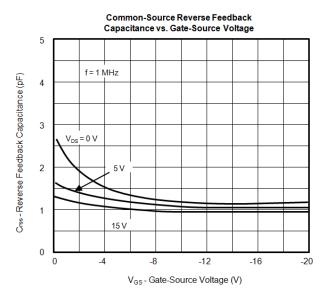


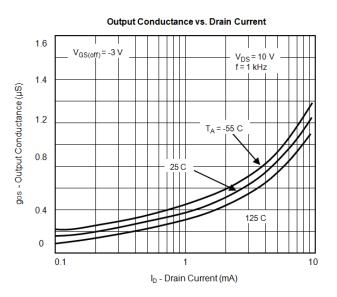
## **Typical Characteristics (Cont'd)**

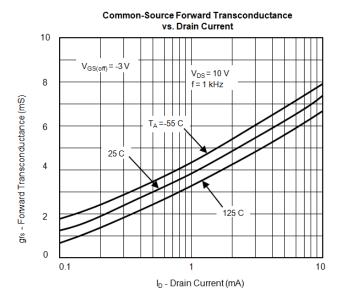


## **Typical Characteristics (Cont'd)**









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